



Latch-up TESTING REPORT

| | |
|--|--|
| Applicant/Department: RAIO TECHNOLOGY INC. | Product: RA8876L4N |
| Case NO: B150428021 | Quantity: 12 ea |
| Test Item: Latch-up (LU) | Package/Pin Count: LQFP_128(14*14) |
| Application Date: 2015/04/28 | Date Finished: 2015/05/15 |
| Reference: JESD78D | Temperature: 85 ± 5 °C Humidity: 55 ± 5% |
| Test Instrument: JB_MK2-5 | Test Voltage: (+)3.3V ~ (+)4.95V Step: (+)0.5V |
| Trigger Current: ±50mA ~ ±200mA Step: ±50mA ; ±125mA ~ ±125mA Step: ±0mA (2015.05.15加測) | |
| Failure Criteria: Device no longer meets the parts drawing requirements using parametric (1.4X INOM or INOM +10mA whichever is greater), functional or IV requirements. | |
| File Name of Raw Data: 50429A_L(RA8876L4N) | |

- NOTE 1:** ESD/latch-up test is employed as one of qualification tests for electronic products. However, the pass / fail results of this test can NOT be taken as go/no-go criteria for IC tape-out and mass production. Before and after ESD/latch-up test(s), complete parametric and functional testing (F/T) are essential for determining pass/fail of the tested products. (References: Page 9, AEC-Q100-003-Rev-E-2003; and Page 15, ESDA-JEDEC JS-001-2011).
- NOTE 2:** MA-tek sample storage policy is 14 days after the test data delivery. Prolonged storage can be arranged per client's request.

WE HEREBY CERTIFY THAT:

The test(s) was/were conducted according to test conditions provided by customer. Testing was performed on calibrated and JEDEC-ESDA qualified ESD instruments. The quality and comprehensiveness of this test(s) were delivered by qualified personnel.

| Tested by | Reviewed by | Approved by |
|----------------|---------------------|------------------|
| <i>yu kang</i> | <i>Jia Ming Lin</i> | <i>Edward Au</i> |

CERTIFICATE of APPROVAL INDEPENDENT TESTING LABORATORY:

ISO9001:2008 Certificate Registration No. 20001845 QM08, issued by UL DQS Inc.
IEC/IECQ17025 Certificate No. IECQ-L ULTW 09.0009, approved by Certification Body (CB): UL Registered Firm





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1. TEST SUMMARY

| | Trigger Model | Test Pin | Sample | Passing Current or Voltage |
|--|---------------------------|----------------------------------|--------|----------------------------|
| IT CLASS: II | +IT | IP,IO,OP_3.3V | 3 | Pass(+100mA) |
| NOTE: | -IT | IP,IO,OP_3.3V | 3 | Pass(-200mA) |
| Class I - Latch-up testing performed at room temperature. | Vsupply Over voltage test | VDD3.3_3.3V | 3 | Pass(+4.95V) |
| | | AVDD33_3.3V | | Pass(+4.95V) |
| Class II - Latch-up testing performed at maximum ambient rated temperature for the device. | +IT | IP,IO,OP_3.3V Test For +125mA | 3 | Pass(+125mA) |
| | | | | |

* DUT failed at the first level of test condition, defined by client.

NOTE: Red color in raw data indicates failed pins, if any.





2. Pin ASSIGNMENT

| Pin Group | PAD Pins |
|-------------|---|
| IO_3.3V | 18 , 19 , 20 , 21 , 22 , 25 , 26 , 27 , 28 , 29 , 30 , 31 , 32 , 33 , 34 , 35 , 37 , 38 , 39 , 40 , 41 , 69 , 70 , 71 , 72 , 73 , 74 , 77 , 78 , 80 , 81 , 82 , 83 , 84 , 85 , 86 , 87 , 90 , 91 , 93 , 94 , 95 , 96 , 99 , 100 , 101 , 102 , 103 , 104 , 105 , 106 , 107 , 108 , 112 , 113 , 116 , 117 , 118 , 119 , 120 , 123 , 124 , 125 , 126 , 127 |
| IP_3.3V | 1 , 6 , 7 , 8 , 9 , 10 , 11 , 12 , 13 , 14 , 15 , 16 , 92 |
| OP_3.3V | 2 , 17 , 36 , 44 , 45 , 46 , 47 , 48 , 49 , 50 , 51 , 52 , 53 , 54 , 55 , 56 , 57 , 58 , 59 , 60 , 61 , 65 , 66 , 67 , 68 , 79 , 128 |
| VDD33_3.3V | 3 , 23 , 42 , 62 , 75 , 88 , 97 , 109 , 121 |
| AVDD33_3.3V | 114 |
| AVSSIO | 115 |
| VSS | 5 , 24 , 43 , 64 , 76 , 89 , 98 , 110 , 122 |



3. ESD TEST CONDITIONS

Testing Combinations

+IT

-IT

OV



4. Raw Data - 2

| Positive Current Trigger(Unit:mA) | | | | | | | | | | | |
|-----------------------------------|-------------|-----|--------|--------|--------|-----------------------|-------------|-----|--------|--------|--------|
| Test Pin Fail Current | | | #01 | #02 | #03 | Test Pin Fail Current | | | #01 | #02 | #03 |
| 1 | XI | 1 | Pass | Pass | Pass | 2 | XO | 2 | Pass | Pass | Pass |
| 4 | LDO_CAP12 | 4 | Pass | Pass | Pass | 6 | XTEST[2:0] | 6 | Pass | Pass | Pass |
| 7 | XTEST[2:0] | 7 | +150mA | +150mA | +150mA | 8 | XTEST[2:0] | 8 | +150mA | +150mA | +150mA |
| 9 | XPS[2:0] | 9 | +150mA | +150mA | +150mA | 10 | XPS[2:0] | 10 | +150mA | +150mA | +150mA |
| 11 | XPS[2:0] | 11 | +150mA | +150mA | +150mA | 12 | XnRST | 12 | +150mA | +150mA | +150mA |
| 13 | XnCS | 13 | +150mA | +150mA | +150mA | 14 | XnRD_EN | 14 | +150mA | +150mA | +150mA |
| 15 | XnWR_RWN | 15 | +150mA | +150mA | +150mA | 16 | XA0 | 16 | +150mA | +150mA | +150mA |
| 17 | XnWAIT | 17 | +200mA | +200mA | +200mA | 18 | XDB[0:4] | 18 | +150mA | +150mA | +150mA |
| 19 | XDB[0:4] | 19 | +150mA | +150mA | +150mA | 20 | XDB[0:4] | 20 | +150mA | +150mA | +150mA |
| 21 | XDB[0:4] | 21 | +150mA | +150mA | +150mA | 22 | XDB[0:4] | 22 | +150mA | +150mA | +150mA |
| 25 | XDB[5:15] | 25 | Pass | Pass | Pass | 26 | XDB[5:15] | 26 | +150mA | +150mA | +150mA |
| 27 | XDB[5:15] | 27 | +150mA | +150mA | +150mA | 28 | XDB[5:15] | 28 | +150mA | +150mA | +150mA |
| 29 | XDB[5:15] | 29 | +150mA | +150mA | +150mA | 30 | XDB[5:15] | 30 | +150mA | +150mA | +150mA |
| 31 | XDB[5:15] | 31 | +150mA | +150mA | +150mA | 32 | XDB[5:15] | 32 | +150mA | +150mA | +150mA |
| 33 | XDB[5:15] | 33 | +150mA | +150mA | +150mA | 34 | XDB[5:15] | 34 | +200mA | +200mA | +200mA |
| 35 | XDB[5:15] | 35 | +200mA | +200mA | +200mA | 36 | XnINTR | 36 | +200mA | +200mA | +200mA |
| 37 | XnSFCS[0:1] | 37 | +200mA | +200mA | +200mA | 38 | XnSFCS[0:1] | 38 | +200mA | +200mA | +200mA |
| 39 | XSCK | 39 | +200mA | +200mA | +200mA | 40 | XMOSI | 40 | +200mA | +200mA | +200mA |
| 41 | XMISO | 41 | +200mA | +200mA | +200mA | 44 | XMBA[1:0] | 44 | +200mA | +200mA | +200mA |
| 45 | XMBA[1:0] | 45 | +200mA | +200mA | +200mA | 46 | XMA[12:0] | 46 | +200mA | +200mA | +200mA |
| 47 | XMA[12:0] | 47 | +200mA | +200mA | +200mA | 48 | XMA[12:0] | 48 | +200mA | +200mA | +200mA |
| 49 | XMA[12:0] | 49 | +200mA | +200mA | +200mA | 50 | XMA[12:0] | 50 | +200mA | +200mA | +200mA |
| 51 | XMA[12:0] | 51 | +200mA | +200mA | +200mA | 52 | XMA[12:0] | 52 | +200mA | +200mA | +200mA |
| 53 | XMA[12:0] | 53 | +200mA | +200mA | +200mA | 54 | XMA[12:0] | 54 | +200mA | +200mA | +200mA |
| 55 | XMA[12:0] | 55 | +200mA | +200mA | +200mA | 56 | XMA[12:0] | 56 | +200mA | +200mA | +200mA |
| 57 | XMA[12:0] | 57 | +200mA | +200mA | +200mA | 58 | XMA[12:0] | 58 | +200mA | +200mA | +200mA |
| 59 | XNMCS | 59 | +200mA | +200mA | +200mA | 60 | XMCKE | 60 | +200mA | +200mA | +200mA |
| 61 | XMCLK | 61 | +200mA | +200mA | +200mA | 63 | LDO_CAP12 | 63 | Pass | Pass | Pass |
| 65 | XnMCAS | 65 | +200mA | +200mA | +200mA | 66 | XnMRAS | 66 | +200mA | +200mA | +200mA |
| 67 | XnMWR | 67 | +200mA | +200mA | +200mA | 68 | XMDQM0 | 68 | +200mA | +200mA | +200mA |
| 69 | XMD[0:5] | 69 | +150mA | +150mA | +150mA | 70 | XMD[0:5] | 70 | +150mA | +150mA | +150mA |
| 71 | XMD[0:5] | 71 | +150mA | +150mA | +150mA | 72 | XMD[0:5] | 72 | +150mA | +150mA | +150mA |
| 73 | XMD[0:5] | 73 | +150mA | +150mA | +150mA | 74 | XMD[0:5] | 74 | +150mA | +150mA | +150mA |
| 77 | XMD[6:7] | 77 | Pass | Pass | Pass | 78 | XMD[6:7] | 78 | +150mA | +150mA | +150mA |
| 79 | XMDQM1 | 79 | +200mA | +200mA | +200mA | 80 | XMD[8:15] | 80 | +150mA | +150mA | +150mA |
| 81 | XMD[8:15] | 81 | Pass | Pass | Pass | 82 | XMD[8:15] | 82 | +150mA | +150mA | +150mA |
| 83 | XMD[8:15] | 83 | +150mA | +150mA | +150mA | 84 | XMD[8:15] | 84 | +150mA | +150mA | +150mA |
| 85 | XMD[8:15] | 85 | +150mA | +150mA | +150mA | 86 | XMD[8:15] | 86 | +150mA | +150mA | +150mA |
| 87 | XMD[8:15] | 87 | +150mA | +150mA | +150mA | 90 | XPWM[0:1] | 90 | +200mA | +200mA | +200mA |
| 91 | XPWM[0:1] | 91 | +200mA | +200mA | +200mA | 92 | XKIN0 | 92 | +150mA | +150mA | +150mA |
| 93 | XVSYNC | 93 | +150mA | +150mA | +150mA | 94 | XHSYNC | 94 | +150mA | +150mA | +150mA |
| 95 | XDE | 95 | +150mA | +150mA | +150mA | 96 | XPCLK | 96 | +150mA | +150mA | +150mA |
| 99 | XPDAT[0:9] | 99 | +200mA | +200mA | +200mA | 100 | XPDAT[0:9] | 100 | +150mA | +150mA | +150mA |
| 101 | XPDAT[0:9] | 101 | +150mA | +150mA | +150mA | 102 | XPDAT[0:9] | 102 | +150mA | +150mA | +150mA |
| 103 | XPDAT[0:9] | 103 | +150mA | +150mA | +150mA | 104 | XPDAT[0:9] | 104 | +150mA | +150mA | +150mA |





4. Raw Data - 2

| Positive Current Trigger(Unit:mA) | | | | | | | | | | | |
|-----------------------------------|--------------|-----|--------|--------|--------|-----------------------|--------------|-----|--------|--------|--------|
| Test Pin Fail Current | | | #01 | #02 | #03 | Test Pin Fail Current | | | #01 | #02 | #03 |
| 105 | XPDAT[0:9] | 105 | +150mA | +150mA | +150mA | 106 | XPDAT[0:9] | 106 | +150mA | +150mA | +150mA |
| 107 | XPDAT[0:9] | 107 | +150mA | +150mA | +150mA | 108 | XPDAT[0:9] | 108 | +150mA | +150mA | +150mA |
| 111 | LDO_CAP12 | 111 | Pass | Pass | Pass | 112 | XPDAT[10:18] | 112 | +200mA | +200mA | +200mA |
| 113 | XPDAT[10:18] | 113 | +150mA | +150mA | +150mA | 116 | XPDAT[10:18] | 116 | +150mA | +150mA | +150mA |
| 117 | XPDAT[10:18] | 117 | +150mA | +150mA | +150mA | 118 | XPDAT[10:18] | 118 | +150mA | +150mA | +150mA |
| 119 | XPDAT[10:18] | 119 | +150mA | +150mA | +150mA | 120 | XPDAT[10:18] | 120 | +150mA | +150mA | +150mA |
| 123 | XPDAT[19:23] | 123 | +200mA | +200mA | +200mA | 124 | XPDAT[19:23] | 124 | +150mA | +150mA | +150mA |
| 125 | XPDAT[19:23] | 125 | +150mA | +150mA | +150mA | 126 | XPDAT[19:23] | 126 | +150mA | +150mA | +150mA |
| 127 | XPDAT[19:23] | 127 | +150mA | +150mA | +150mA | 128 | XKOUT0 | 128 | +150mA | +150mA | +150mA |





4. Raw Data - 2

| Negative Current Trigger(Unit:mA) | | | | | | | | | | | |
|-----------------------------------|-------------|-----|------|------|------|-----------------------|-------------|-----|------|------|------|
| Test Pin Fail Current | | | #01 | #02 | #03 | Test Pin Fail Current | | | #01 | #02 | #03 |
| 1 | XI | 1 | Pass | Pass | Pass | 2 | XO | 2 | Pass | Pass | Pass |
| 4 | LDO_CAP12 | 4 | Pass | Pass | Pass | 6 | XTEST[2:0] | 6 | Pass | Pass | Pass |
| 7 | XTEST[2:0] | 7 | Pass | Pass | Pass | 8 | XTEST[2:0] | 8 | Pass | Pass | Pass |
| 9 | XPS[2:0] | 9 | Pass | Pass | Pass | 10 | XPS[2:0] | 10 | Pass | Pass | Pass |
| 11 | XPS[2:0] | 11 | Pass | Pass | Pass | 12 | XnRST | 12 | Pass | Pass | Pass |
| 13 | XnCS | 13 | Pass | Pass | Pass | 14 | XnRD_EN | 14 | Pass | Pass | Pass |
| 15 | XnWR_RWN | 15 | Pass | Pass | Pass | 16 | XA0 | 16 | Pass | Pass | Pass |
| 17 | XnWAIT | 17 | Pass | Pass | Pass | 18 | XDB[0:4] | 18 | Pass | Pass | Pass |
| 19 | XDB[0:4] | 19 | Pass | Pass | Pass | 20 | XDB[0:4] | 20 | Pass | Pass | Pass |
| 21 | XDB[0:4] | 21 | Pass | Pass | Pass | 22 | XDB[0:4] | 22 | Pass | Pass | Pass |
| 25 | XDB[5:15] | 25 | Pass | Pass | Pass | 26 | XDB[5:15] | 26 | Pass | Pass | Pass |
| 27 | XDB[5:15] | 27 | Pass | Pass | Pass | 28 | XDB[5:15] | 28 | Pass | Pass | Pass |
| 29 | XDB[5:15] | 29 | Pass | Pass | Pass | 30 | XDB[5:15] | 30 | Pass | Pass | Pass |
| 31 | XDB[5:15] | 31 | Pass | Pass | Pass | 32 | XDB[5:15] | 32 | Pass | Pass | Pass |
| 33 | XDB[5:15] | 33 | Pass | Pass | Pass | 34 | XDB[5:15] | 34 | Pass | Pass | Pass |
| 35 | XDB[5:15] | 35 | Pass | Pass | Pass | 36 | XnINTR | 36 | Pass | Pass | Pass |
| 37 | XnSFCS[0:1] | 37 | Pass | Pass | Pass | 38 | XnSFCS[0:1] | 38 | Pass | Pass | Pass |
| 39 | XSCK | 39 | Pass | Pass | Pass | 40 | XMOSI | 40 | Pass | Pass | Pass |
| 41 | XMISO | 41 | Pass | Pass | Pass | 44 | XMBA[1:0] | 44 | Pass | Pass | Pass |
| 45 | XMBA[1:0] | 45 | Pass | Pass | Pass | 46 | XMA[12:0] | 46 | Pass | Pass | Pass |
| 47 | XMA[12:0] | 47 | Pass | Pass | Pass | 48 | XMA[12:0] | 48 | Pass | Pass | Pass |
| 49 | XMA[12:0] | 49 | Pass | Pass | Pass | 50 | XMA[12:0] | 50 | Pass | Pass | Pass |
| 51 | XMA[12:0] | 51 | Pass | Pass | Pass | 52 | XMA[12:0] | 52 | Pass | Pass | Pass |
| 53 | XMA[12:0] | 53 | Pass | Pass | Pass | 54 | XMA[12:0] | 54 | Pass | Pass | Pass |
| 55 | XMA[12:0] | 55 | Pass | Pass | Pass | 56 | XMA[12:0] | 56 | Pass | Pass | Pass |
| 57 | XMA[12:0] | 57 | Pass | Pass | Pass | 58 | XMA[12:0] | 58 | Pass | Pass | Pass |
| 59 | XNMCS | 59 | Pass | Pass | Pass | 60 | XMCKE | 60 | Pass | Pass | Pass |
| 61 | XMCLK | 61 | Pass | Pass | Pass | 63 | LDO_CAP12 | 63 | Pass | Pass | Pass |
| 65 | XnMCAS | 65 | Pass | Pass | Pass | 66 | XnMRAS | 66 | Pass | Pass | Pass |
| 67 | XnMWR | 67 | Pass | Pass | Pass | 68 | XMDQM0 | 68 | Pass | Pass | Pass |
| 69 | XMD[0:5] | 69 | Pass | Pass | Pass | 70 | XMD[0:5] | 70 | Pass | Pass | Pass |
| 71 | XMD[0:5] | 71 | Pass | Pass | Pass | 72 | XMD[0:5] | 72 | Pass | Pass | Pass |
| 73 | XMD[0:5] | 73 | Pass | Pass | Pass | 74 | XMD[0:5] | 74 | Pass | Pass | Pass |
| 77 | XMD[6:7] | 77 | Pass | Pass | Pass | 78 | XMD[6:7] | 78 | Pass | Pass | Pass |
| 79 | XMDQM1 | 79 | Pass | Pass | Pass | 80 | XMD[8:15] | 80 | Pass | Pass | Pass |
| 81 | XMD[8:15] | 81 | Pass | Pass | Pass | 82 | XMD[8:15] | 82 | Pass | Pass | Pass |
| 83 | XMD[8:15] | 83 | Pass | Pass | Pass | 84 | XMD[8:15] | 84 | Pass | Pass | Pass |
| 85 | XMD[8:15] | 85 | Pass | Pass | Pass | 86 | XMD[8:15] | 86 | Pass | Pass | Pass |
| 87 | XMD[8:15] | 87 | Pass | Pass | Pass | 90 | XPWM[0:1] | 90 | Pass | Pass | Pass |
| 91 | XPWM[0:1] | 91 | Pass | Pass | Pass | 92 | XKIN0 | 92 | Pass | Pass | Pass |
| 93 | XVSYNC | 93 | Pass | Pass | Pass | 94 | XHSYNC | 94 | Pass | Pass | Pass |
| 95 | XDE | 95 | Pass | Pass | Pass | 96 | XPCLK | 96 | Pass | Pass | Pass |
| 99 | XPDAT[0:9] | 99 | Pass | Pass | Pass | 100 | XPDAT[0:9] | 100 | Pass | Pass | Pass |
| 101 | XPDAT[0:9] | 101 | Pass | Pass | Pass | 102 | XPDAT[0:9] | 102 | Pass | Pass | Pass |
| 103 | XPDAT[0:9] | 103 | Pass | Pass | Pass | 104 | XPDAT[0:9] | 104 | Pass | Pass | Pass |





4. Raw Data - 2

| Negative Current Trigger(Unit:mA) | | | | | | | | | | | |
|-----------------------------------|--------------|-----|------|------|------|-----------------------|--------------|-----|------|------|------|
| Test Pin Fail Current | | | #01 | #02 | #03 | Test Pin Fail Current | | | #01 | #02 | #03 |
| 105 | XPDAT[0:9] | 105 | Pass | Pass | Pass | 106 | XPDAT[0:9] | 106 | Pass | Pass | Pass |
| 107 | XPDAT[0:9] | 107 | Pass | Pass | Pass | 108 | XPDAT[0:9] | 108 | Pass | Pass | Pass |
| 111 | LDO_CAP12 | 111 | Pass | Pass | Pass | 112 | XPDAT[10:18] | 112 | Pass | Pass | Pass |
| 113 | XPDAT[10:18] | 113 | Pass | Pass | Pass | 116 | XPDAT[10:18] | 116 | Pass | Pass | Pass |
| 117 | XPDAT[10:18] | 117 | Pass | Pass | Pass | 118 | XPDAT[10:18] | 118 | Pass | Pass | Pass |
| 119 | XPDAT[10:18] | 119 | Pass | Pass | Pass | 120 | XPDAT[10:18] | 120 | Pass | Pass | Pass |
| 123 | XPDAT[19:23] | 123 | Pass | Pass | Pass | 124 | XPDAT[19:23] | 124 | Pass | Pass | Pass |
| 125 | XPDAT[19:23] | 125 | Pass | Pass | Pass | 126 | XPDAT[19:23] | 126 | Pass | Pass | Pass |
| 127 | XPDAT[19:23] | 127 | Pass | Pass | Pass | 128 | XKOUT0 | 128 | Pass | Pass | Pass |





4. Raw Data - 2

| V supply Over Voltage Test(Unit: V) | | | | | | | | | | | |
|-------------------------------------|--------------|-----|------|------|------|-----------------------|-------|-----|------|------|------|
| Test Pin Fail Voltage | | | #01 | #02 | #03 | Test Pin Fail Voltage | | | #01 | #02 | #03 |
| 3 | VDD33 | 3 | Pass | Pass | Pass | 23 | VDD33 | 23 | Pass | Pass | Pass |
| 42 | VDD33 | 42 | Pass | Pass | Pass | 62 | VDD33 | 62 | Pass | Pass | Pass |
| 75 | VDD33 | 75 | Pass | Pass | Pass | 88 | VDD33 | 88 | Pass | Pass | Pass |
| 97 | VDD33 | 97 | Pass | Pass | Pass | 109 | VDD33 | 109 | Pass | Pass | Pass |
| 114 | XPDAT[10:18] | 114 | Pass | Pass | Pass | 121 | VDD33 | 121 | Pass | Pass | Pass |





4. Raw Data - 2

| Positive Current Trigger(Unit: +125mA) | | | | | | | | | | | |
|--|-------------|-----|------|------|------|-----------------------|-------------|-----|------|------|------|
| Test Pin Fail Current | | | #01 | #02 | #03 | Test Pin Fail Current | | | #01 | #02 | #03 |
| 1 | XI | 1 | Pass | Pass | Pass | 2 | XO | 2 | Pass | Pass | Pass |
| 4 | LDO_CAP12 | 4 | Pass | Pass | Pass | 6 | XTEST[2:0] | 6 | Pass | Pass | Pass |
| 7 | XTEST[2:0] | 7 | Pass | Pass | Pass | 8 | XTEST[2:0] | 8 | Pass | Pass | Pass |
| 9 | XPS[2:0] | 9 | Pass | Pass | Pass | 10 | XPS[2:0] | 10 | Pass | Pass | Pass |
| 11 | XPS[2:0] | 11 | Pass | Pass | Pass | 12 | XnRST | 12 | Pass | Pass | Pass |
| 13 | XnCS | 13 | Pass | Pass | Pass | 14 | XnRD_EN | 14 | Pass | Pass | Pass |
| 15 | XnWR_RWN | 15 | Pass | Pass | Pass | 16 | XA0 | 16 | Pass | Pass | Pass |
| 17 | XnWAIT | 17 | Pass | Pass | Pass | 18 | XDB[0:4] | 18 | Pass | Pass | Pass |
| 19 | XDB[0:4] | 19 | Pass | Pass | Pass | 20 | XDB[0:4] | 20 | Pass | Pass | Pass |
| 21 | XDB[0:4] | 21 | Pass | Pass | Pass | 22 | XDB[0:4] | 22 | Pass | Pass | Pass |
| 25 | XDB[5:15] | 25 | Pass | Pass | Pass | 26 | XDB[5:15] | 26 | Pass | Pass | Pass |
| 27 | XDB[5:15] | 27 | Pass | Pass | Pass | 28 | XDB[5:15] | 28 | Pass | Pass | Pass |
| 29 | XDB[5:15] | 29 | Pass | Pass | Pass | 30 | XDB[5:15] | 30 | Pass | Pass | Pass |
| 31 | XDB[5:15] | 31 | Pass | Pass | Pass | 32 | XDB[5:15] | 32 | Pass | Pass | Pass |
| 33 | XDB[5:15] | 33 | Pass | Pass | Pass | 34 | XDB[5:15] | 34 | Pass | Pass | Pass |
| 35 | XDB[5:15] | 35 | Pass | Pass | Pass | 36 | XnINTR | 36 | Pass | Pass | Pass |
| 37 | XnSFCS[0:1] | 37 | Pass | Pass | Pass | 38 | XnSFCS[0:1] | 38 | Pass | Pass | Pass |
| 39 | XSCK | 39 | Pass | Pass | Pass | 40 | XMOSI | 40 | Pass | Pass | Pass |
| 41 | XMISO | 41 | Pass | Pass | Pass | 44 | XMBA[1:0] | 44 | Pass | Pass | Pass |
| 45 | XMBA[1:0] | 45 | Pass | Pass | Pass | 46 | XMA[12:0] | 46 | Pass | Pass | Pass |
| 47 | XMA[12:0] | 47 | Pass | Pass | Pass | 48 | XMA[12:0] | 48 | Pass | Pass | Pass |
| 49 | XMA[12:0] | 49 | Pass | Pass | Pass | 50 | XMA[12:0] | 50 | Pass | Pass | Pass |
| 51 | XMA[12:0] | 51 | Pass | Pass | Pass | 52 | XMA[12:0] | 52 | Pass | Pass | Pass |
| 53 | XMA[12:0] | 53 | Pass | Pass | Pass | 54 | XMA[12:0] | 54 | Pass | Pass | Pass |
| 55 | XMA[12:0] | 55 | Pass | Pass | Pass | 56 | XMA[12:0] | 56 | Pass | Pass | Pass |
| 57 | XMA[12:0] | 57 | Pass | Pass | Pass | 58 | XMA[12:0] | 58 | Pass | Pass | Pass |
| 59 | XNMCS | 59 | Pass | Pass | Pass | 60 | XMCKE | 60 | Pass | Pass | Pass |
| 61 | XMCLK | 61 | Pass | Pass | Pass | 63 | LDO_CAP12 | 63 | Pass | Pass | Pass |
| 65 | XnMCAS | 65 | Pass | Pass | Pass | 66 | XnMRAS | 66 | Pass | Pass | Pass |
| 67 | XnMWR | 67 | Pass | Pass | Pass | 68 | XMDQM0 | 68 | Pass | Pass | Pass |
| 69 | XMD[0:5] | 69 | Pass | Pass | Pass | 70 | XMD[0:5] | 70 | Pass | Pass | Pass |
| 71 | XMD[0:5] | 71 | Pass | Pass | Pass | 72 | XMD[0:5] | 72 | Pass | Pass | Pass |
| 73 | XMD[0:5] | 73 | Pass | Pass | Pass | 74 | XMD[0:5] | 74 | Pass | Pass | Pass |
| 77 | XMD[6:7] | 77 | Pass | Pass | Pass | 78 | XMD[6:7] | 78 | Pass | Pass | Pass |
| 79 | XMDQM1 | 79 | Pass | Pass | Pass | 80 | XMD[8:15] | 80 | Pass | Pass | Pass |
| 81 | XMD[8:15] | 81 | Pass | Pass | Pass | 82 | XMD[8:15] | 82 | Pass | Pass | Pass |
| 83 | XMD[8:15] | 83 | Pass | Pass | Pass | 84 | XMD[8:15] | 84 | Pass | Pass | Pass |
| 85 | XMD[8:15] | 85 | Pass | Pass | Pass | 86 | XMD[8:15] | 86 | Pass | Pass | Pass |
| 87 | XMD[8:15] | 87 | Pass | Pass | Pass | 90 | XPWM[0:1] | 90 | Pass | Pass | Pass |
| 91 | XPWM[0:1] | 91 | Pass | Pass | Pass | 92 | XKIN0 | 92 | Pass | Pass | Pass |
| 93 | XVSYNC | 93 | Pass | Pass | Pass | 94 | XHSYNC | 94 | Pass | Pass | Pass |
| 95 | XDE | 95 | Pass | Pass | Pass | 96 | XPCLK | 96 | Pass | Pass | Pass |
| 99 | XPDAT[0:9] | 99 | Pass | Pass | Pass | 100 | XPDAT[0:9] | 100 | Pass | Pass | Pass |
| 101 | XPDAT[0:9] | 101 | Pass | Pass | Pass | 102 | XPDAT[0:9] | 102 | Pass | Pass | Pass |
| 103 | XPDAT[0:9] | 103 | Pass | Pass | Pass | 104 | XPDAT[0:9] | 104 | Pass | Pass | Pass |





4. Raw Data - 2

| Positive Current Trigger(Unit: +125mA) | | | | | | | | | | | |
|--|--------------|-----|------|------|------|-----------------------|--------------|-----|------|------|------|
| Test Pin Fail Current | | | #01 | #02 | #03 | Test Pin Fail Current | | | #01 | #02 | #03 |
| 105 | XPDAT[0:9] | 105 | Pass | Pass | Pass | 106 | XPDAT[0:9] | 106 | Pass | Pass | Pass |
| 107 | XPDAT[0:9] | 107 | Pass | Pass | Pass | 108 | XPDAT[0:9] | 108 | Pass | Pass | Pass |
| 111 | LDO_CAP12 | 111 | Pass | Pass | Pass | 112 | XPDAT[10:18] | 112 | Pass | Pass | Pass |
| 113 | XPDAT[10:18] | 113 | Pass | Pass | Pass | 116 | XPDAT[10:18] | 116 | Pass | Pass | Pass |
| 117 | XPDAT[10:18] | 117 | Pass | Pass | Pass | 118 | XPDAT[10:18] | 118 | Pass | Pass | Pass |
| 119 | XPDAT[10:18] | 119 | Pass | Pass | Pass | 120 | XPDAT[10:18] | 120 | Pass | Pass | Pass |
| 123 | XPDAT[19:23] | 123 | Pass | Pass | Pass | 124 | XPDAT[19:23] | 124 | Pass | Pass | Pass |
| 125 | XPDAT[19:23] | 125 | Pass | Pass | Pass | 126 | XPDAT[19:23] | 126 | Pass | Pass | Pass |
| 127 | XPDAT[19:23] | 127 | Pass | Pass | Pass | 128 | XKOUT0 | 128 | Pass | Pass | Pass |



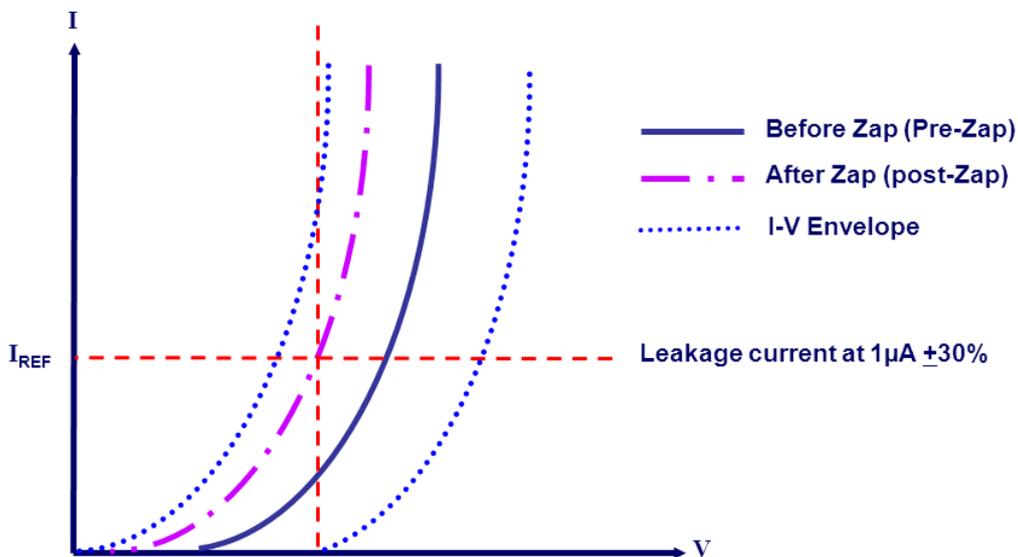
5. APPENDIX-1 (PASS/FAIL CRITERIA)

FAILURE CRITERIA

Device no longer meets the parts drawing requirements using parametric (1.4X INOM or INOM +10mA whichever is greater), functional or IV requirements.

Note

For custom designed ESD testing customers may select variation in I_{dd}, and leakage current as criteria to determine pass/fail results of ESD testing.



Pass/Fail Criteria:
Variation of Leakage Current and I-V Shift in Pre-Zap and Post-Zap curves



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6. APPENDIX-2 (ESD INSTRUMENTATION AT MA-TEK)

| No. | Test Tools | Vendors | System Specification |
|-----|------------------------|-------------------|--|
| 1 | Zapmaster | Thermo Keytek | 256 Pin Count, ESD Pulse 50 V to 8 KV |
| 2 | MK2 | Thermo Keytek | 768 Pin Count, ESD Pulse 10 V to 8 KV |
| 3 | MK1 | Thermo Scientific | 256 Pin Count, ESD Pulse 10 V to 8 KV |
| 4 | CDM Tester | Oryx Orion | 100 V to 2 KV |
| 5 | ESD Gun | Noiseken | Voltage = 1 V to 1 KV, Current = 10 nA to 20 A |
| 6 | High Temp. Test Module | Thermonics | Maximum temperature = 150°C. |
| 7 | TLP Tester | Thermo Scientific | Voltage = 1 V to 1 KV, Current = 10 nA to 20 A |

